

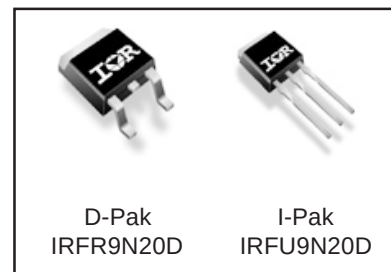
### Applications

- High frequency DC-DC converters

| $V_{DSS}$ | $R_{DS(on)}$ max | $I_D$ |
|-----------|------------------|-------|
| 200V      | 0.38 $\Omega$    | 9.4A  |

### Benefits

- Low Gate-to-Drain Charge to Reduce Switching Losses
- Fully Characterized Capacitance Including Effective  $C_{OSS}$  to Simplify Design, (See App. Note AN1001)
- Fully Characterized Avalanche Voltage and Current



### Absolute Maximum Ratings

|                                   | Parameter                                | Max.                   | Units               |
|-----------------------------------|------------------------------------------|------------------------|---------------------|
| $I_D$ @ $T_C = 25^\circ\text{C}$  | Continuous Drain Current, $V_{GS}$ @ 10V | 9.4                    | A                   |
| $I_D$ @ $T_C = 100^\circ\text{C}$ | Continuous Drain Current, $V_{GS}$ @ 10V | 6.7                    |                     |
| $I_{DM}$                          | Pulsed Drain Current ①                   | 38                     |                     |
| $P_D$ @ $T_C = 25^\circ\text{C}$  | Power Dissipation                        | 86                     | W                   |
|                                   | Linear Derating Factor                   | 0.57                   | W/ $^\circ\text{C}$ |
| $V_{GS}$                          | Gate-to-Source Voltage                   | $\pm 30$               | V                   |
| $dv/dt$                           | Peak Diode Recovery $dv/dt$ ③            | 5.0                    | V/ns                |
| $T_J$                             | Operating Junction and                   | -55 to + 175           | $^\circ\text{C}$    |
| $T_{STG}$                         | Storage Temperature Range                |                        |                     |
|                                   | Soldering Temperature, for 10 seconds    | 300 (1.6mm from case ) |                     |

### Typical SMPS Topologies

- Telecom 48V input Forward Converter

Notes ① through ⑥ are on page 10

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# IRFR9N20D/IRFU9N20D

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Static @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)

|                                 | Parameter                            | Min. | Typ. | Max. | Units    | Conditions                                            |
|---------------------------------|--------------------------------------|------|------|------|----------|-------------------------------------------------------|
| $V_{(BR)DSS}$                   | Drain-to-Source Breakdown Voltage    | 200  | —    | —    | V        | $V_{GS} = 0V, I_D = 250\mu A$                         |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient  | —    | 0.23 | —    | V/°C     | Reference to $25^\circ\text{C}, I_D = 1mA$ ⑥          |
| $R_{DS(on)}$                    | Static Drain-to-Source On-Resistance | —    | —    | 0.38 | $\Omega$ | $V_{GS} = 10V, I_D = 5.6A$ ④                          |
| $V_{GS(th)}$                    | Gate Threshold Voltage               | 3.0  | —    | 5.5  | V        | $V_{DS} = V_{GS}, I_D = 250\mu A$                     |
| $I_{DSS}$                       | Drain-to-Source Leakage Current      | —    | —    | 25   | $\mu A$  | $V_{DS} = 200V, V_{GS} = 0V$                          |
|                                 |                                      | —    | —    | 250  |          | $V_{DS} = 160V, V_{GS} = 0V, T_J = 150^\circ\text{C}$ |
| $I_{GSS}$                       | Gate-to-Source Forward Leakage       | —    | —    | 100  | nA       | $V_{GS} = 30V$                                        |
|                                 | Gate-to-Source Reverse Leakage       | —    | —    | -100 |          | $V_{GS} = -30V$                                       |

Dynamic @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)

|                        | Parameter                       | Min. | Typ. | Max. | Units | Conditions                                    |
|------------------------|---------------------------------|------|------|------|-------|-----------------------------------------------|
| $g_{fs}$               | Forward Transconductance        | 4.3  | —    | —    | S     | $V_{DS} = 50V, I_D = 5.6A$                    |
| $Q_g$                  | Total Gate Charge               | —    | 18   | 27   | nC    | $I_D = 5.6A$                                  |
| $Q_{gs}$               | Gate-to-Source Charge           | —    | 4.7  | 7.1  |       | $V_{DS} = 160V$                               |
| $Q_{gd}$               | Gate-to-Drain ("Miller") Charge | —    | 9.0  | 14   |       | $V_{GS} = 10V$ ④                              |
| $t_{d(on)}$            | Turn-On Delay Time              | —    | 7.5  | —    | ns    | $V_{DD} = 100V$                               |
| $t_r$                  | Rise Time                       | —    | 16   | —    |       | $I_D = 5.6A$                                  |
| $t_{d(off)}$           | Turn-Off Delay Time             | —    | 13   | —    |       | $R_G = 11\Omega$                              |
| $t_f$                  | Fall Time                       | —    | 9.3  | —    |       | $V_{GS} = 10V$ ④                              |
| $C_{iss}$              | Input Capacitance               | —    | 560  | —    | pF    | $V_{GS} = 0V$                                 |
| $C_{oss}$              | Output Capacitance              | —    | 97   | —    |       | $V_{DS} = 25V$                                |
| $C_{rss}$              | Reverse Transfer Capacitance    | —    | 29   | —    |       | $f = 1.0MHz$                                  |
| $C_{oss}$              | Output Capacitance              | —    | 670  | —    |       | $V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0MHz$      |
| $C_{oss}$              | Output Capacitance              | —    | 40   | —    |       | $V_{GS} = 0V, V_{DS} = 160V, f = 1.0MHz$      |
| $C_{oss \text{ eff.}}$ | Effective Output Capacitance    | —    | 74   | —    |       | $V_{GS} = 0V, V_{DS} = 0V \text{ to } 160V$ ⑤ |

## Avalanche Characteristics

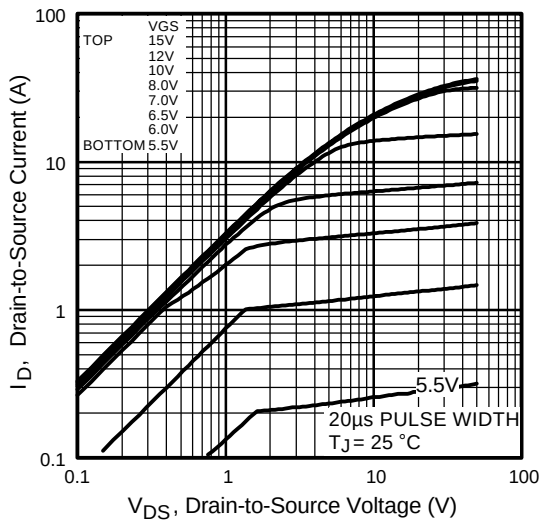
|          | Parameter                      | Typ. | Max. | Units |
|----------|--------------------------------|------|------|-------|
| $E_{AS}$ | Single Pulse Avalanche Energy② | —    | 100  | mJ    |
| $I_{AR}$ | Avalanche Current①             | —    | 5.6  | A     |
| $E_{AR}$ | Repetitive Avalanche Energy①   | —    | 8.6  | mJ    |

## Thermal Resistance

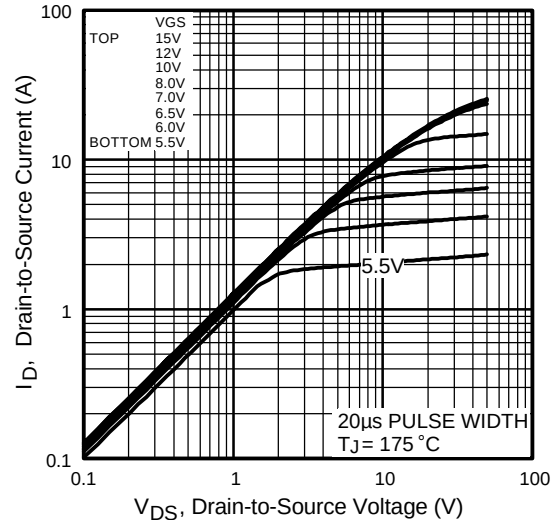
|                 | Parameter                        | Typ. | Max. | Units |
|-----------------|----------------------------------|------|------|-------|
| $R_{\theta JC}$ | Junction-to-Case                 | —    | 1.75 | °C/W  |
| $R_{\theta JA}$ | Junction-to-Ambient (PCB mount)* | —    | 50   |       |
| $R_{\theta JA}$ | Junction-to-Ambient              | —    | 110  |       |

## Diode Characteristics

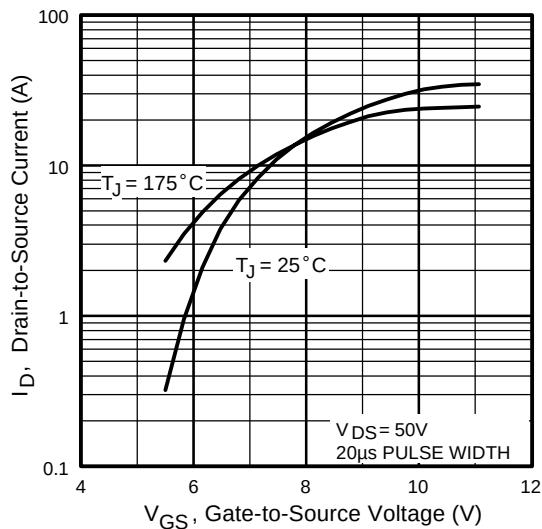
|          | Parameter                              | Min.                                                                        | Typ. | Max. | Units | Conditions                                                     |
|----------|----------------------------------------|-----------------------------------------------------------------------------|------|------|-------|----------------------------------------------------------------|
| $I_S$    | Continuous Source Current (Body Diode) | —                                                                           | —    | 9.4  | A     | MOSFET symbol showing the integral reverse p-n junction diode. |
| $I_{SM}$ | Pulsed Source Current (Body Diode) ①   | —                                                                           | —    | 38   |       |                                                                |
| $V_{SD}$ | Diode Forward Voltage                  | —                                                                           | —    | 1.3  | V     | $T_J = 25^\circ\text{C}, I_S = 5.6A, V_{GS} = 0V$ ④            |
| $t_{rr}$ | Reverse Recovery Time                  | —                                                                           | 130  | —    | ns    | $T_J = 25^\circ\text{C}, I_F = 5.6A$                           |
| $Q_{rr}$ | Reverse Recovery Charge                | —                                                                           | 560  | —    | nC    | $di/dt = 100A/\mu s$ ④                                         |
| $t_{on}$ | Forward Turn-On Time                   | Intrinsic turn-on time is negligible (turn-on is dominated by $L_S + L_D$ ) |      |      |       |                                                                |



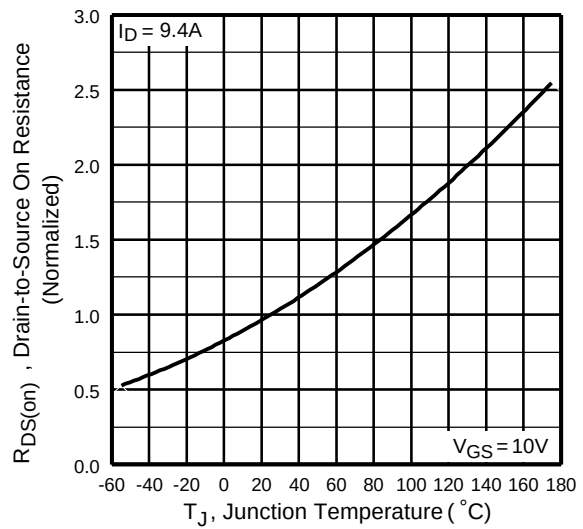
**Fig 1.** Typical Output Characteristics



**Fig 2.** Typical Output Characteristics



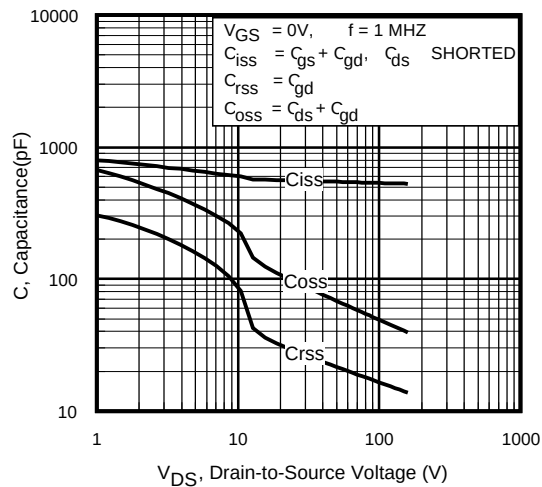
**Fig 3.** Typical Transfer Characteristics



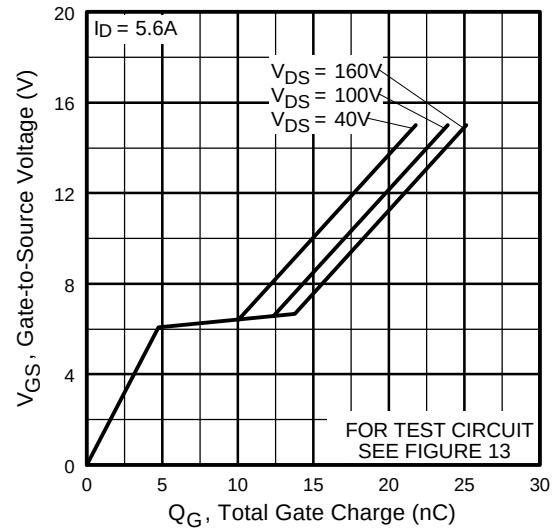
**Fig 4.** Normalized On-Resistance Vs. Temperature

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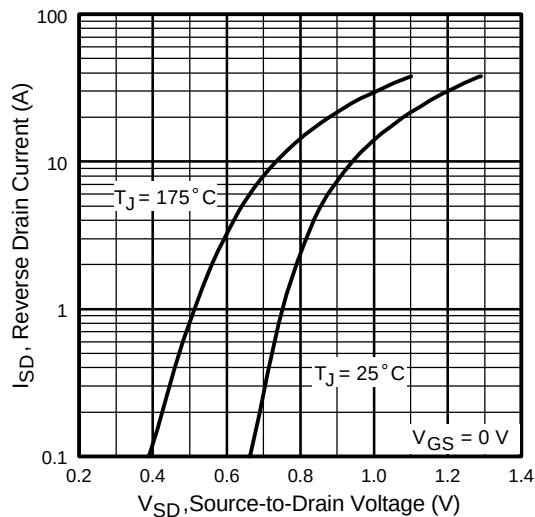
International  
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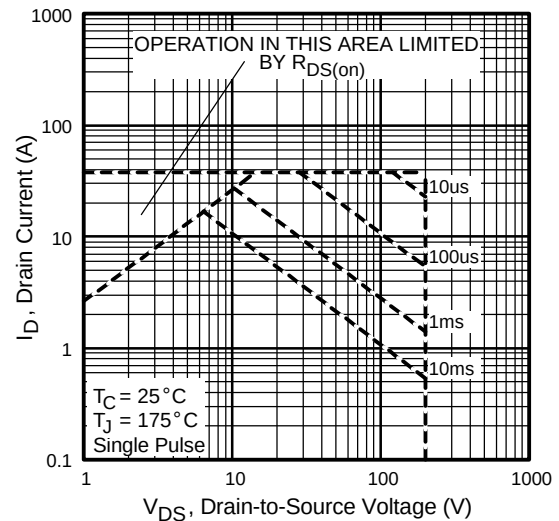
**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage



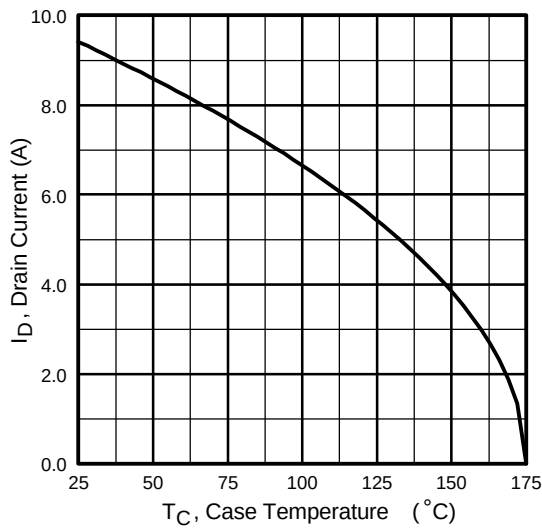
**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage



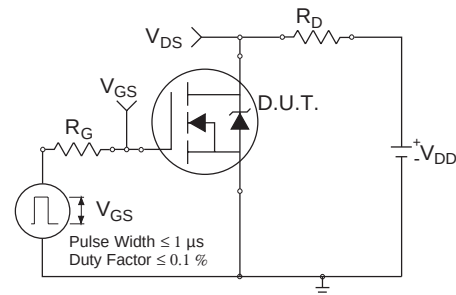
**Fig 7.** Typical Source-Drain Diode Forward Voltage



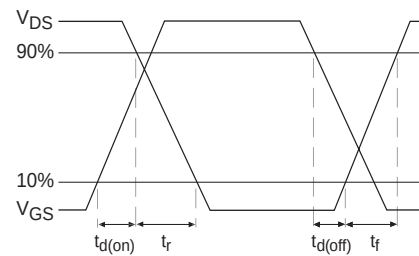
**Fig 8.** Maximum Safe Operating Area



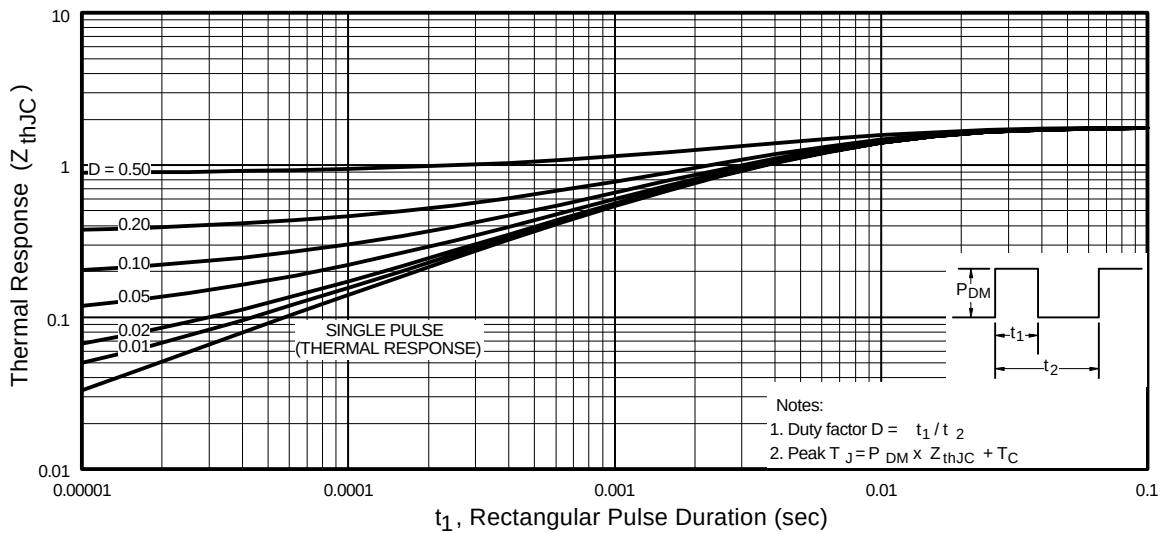
**Fig 9.** Maximum Drain Current Vs. Case Temperature



**Fig 10a.** Switching Time Test Circuit



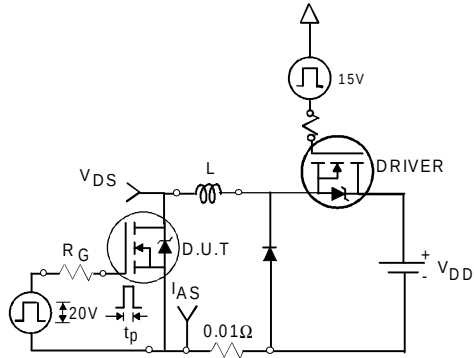
**Fig 10b.** Switching Time Waveforms



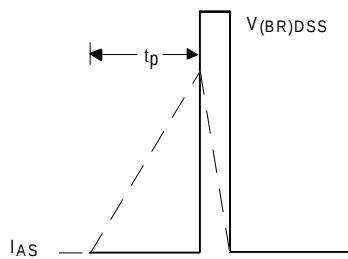
**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case

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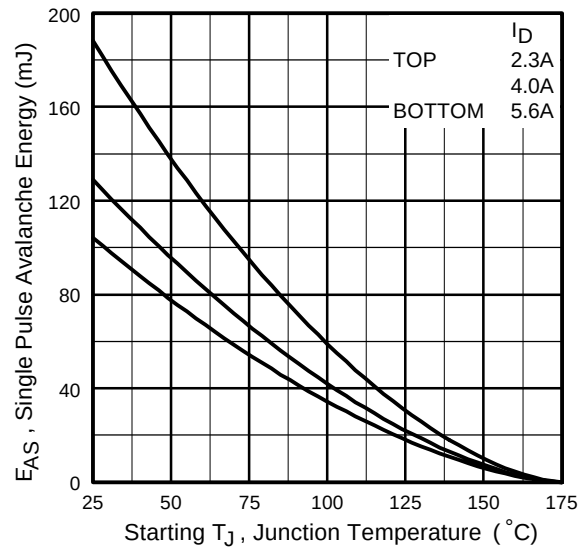
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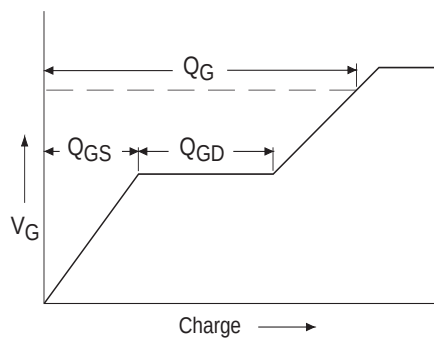
**Fig 12a.** Unclamped Inductive Test Circuit



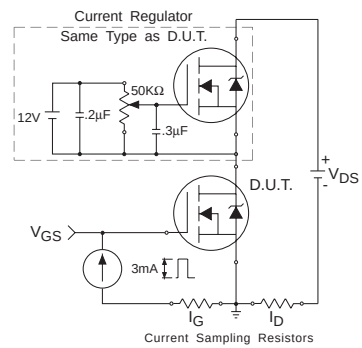
**Fig 12b.** Unclamped Inductive Waveforms



**Fig 12c.** Maximum Avalanche Energy Vs. Drain Current

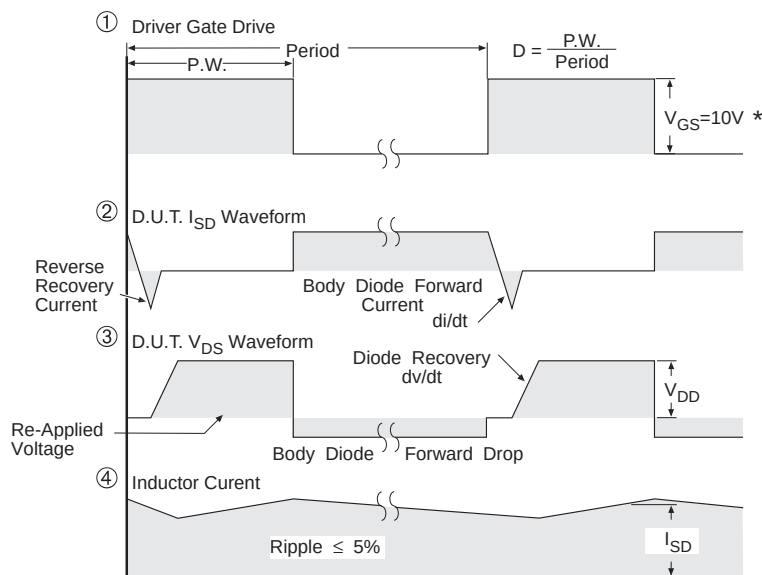
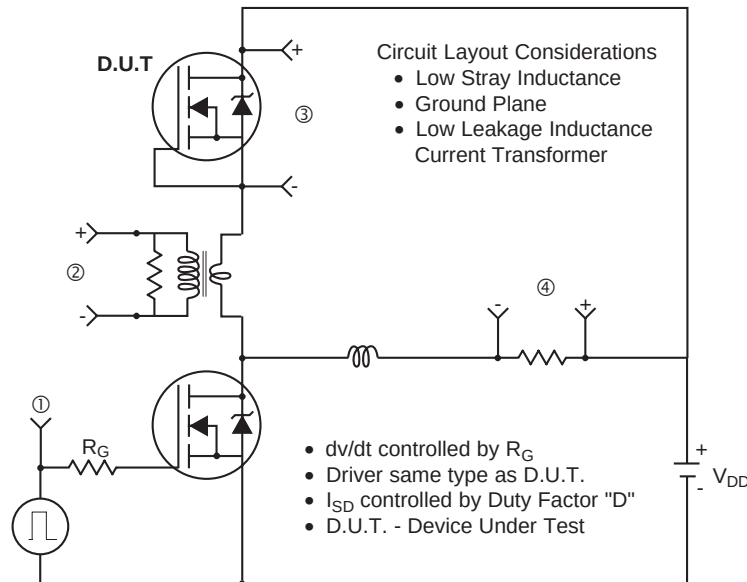


**Fig 13a.** Basic Gate Charge Waveform



**Fig 13b.** Gate Charge Test Circuit

## Peak Diode Recovery dv/dt Test Circuit



\*  $V_{GS} = 5V$  for Logic Level Devices

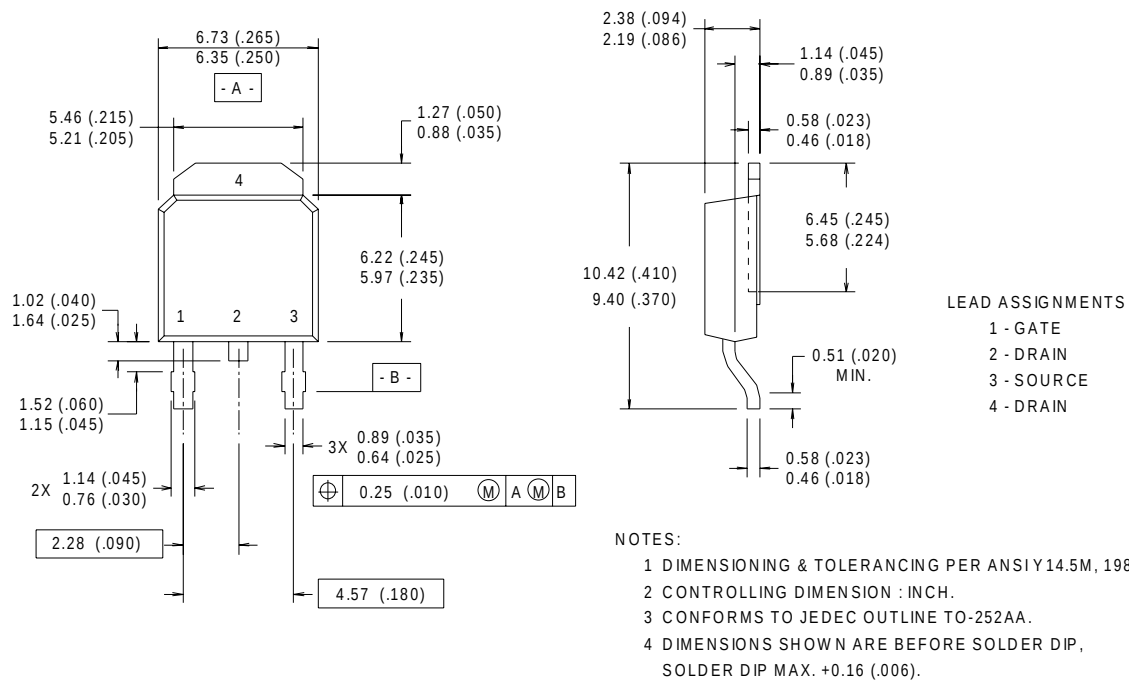
**Fig 14.** For N-Channel HEXFET® Power MOSFETs

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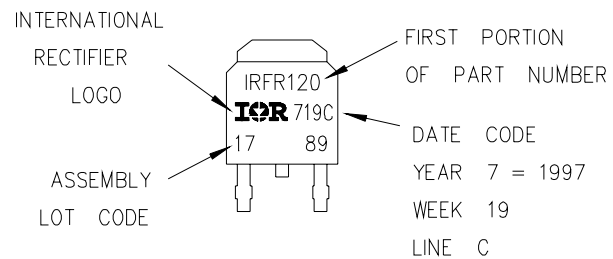
## D-Pak (TO-252AA) Package Outline

Dimensions are shown in millimeters (inches)



## D-Pak (TO-252AA) Part Marking Information

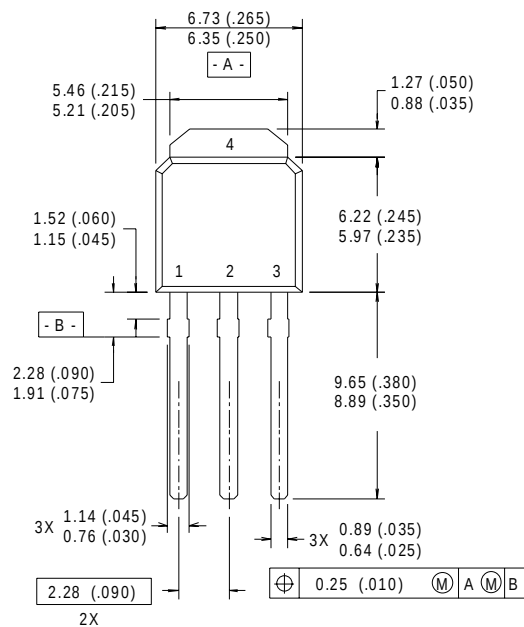
EXAMPLE: THIS IS AN IRFR120  
LOT CODE 1789  
ASSEMBLED ON WW 19, 1997  
IN THE ASSEMBLY LINE "C"





## I-Pak (TO-251AA) Package Outline

Dimensions are shown in millimeters (inches)



### LEAD ASSIGNMENTS

- 1 - GATE
- 2 - DRAIN
- 3 - SOURCE
- 4 - DRAIN

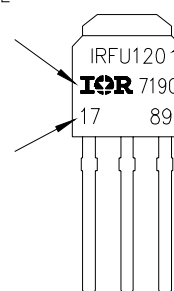
### NOTES:

- 1 DIMENSIONING & TOLERANCING PER ANSI Y14.5M, 1982.
- 2 CONTROLLING DIMENSION : INCH.
- 3 CONFORMS TO JEDEC OUTLINE TO-252AA.
- 4 DIMENSIONS SHOWN ARE BEFORE SOLDER DIP, SOLDER DIP MAX. +0.16 (.006).

## I-Pak (TO-251AA) Part Marking Information

EXAMPLE: THIS IS AN IRFU120  
LOT CODE 1789  
ASSEMBLED ON WW 19, 1997  
IN THE ASSEMBLY LINE "C"

INTERNATIONAL  
RECTIFIER  
LOGO  
ASSEMBLY  
LOT CODE



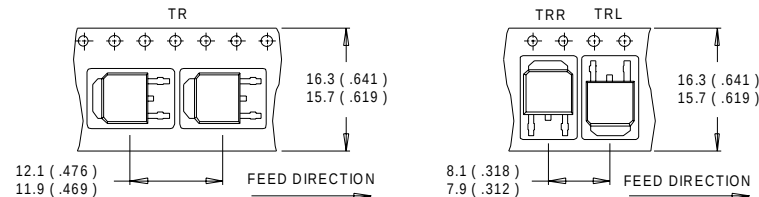
FIRST PORTION  
OF PART NUMBER  
DATE CODE  
YEAR 7 = 1997  
WEEK 19  
LINE C

# IRFR9N20D/IRFU9N20D

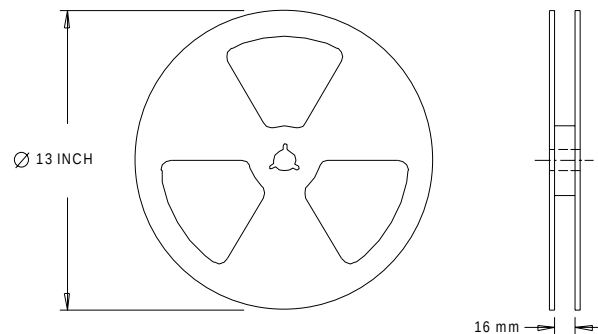
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## D-Pak (TO-252AA) Tape & Reel Information

Dimensions are shown in millimeters (inches)



- NOTES :
1. CONTROLLING DIMENSION : MILLIMETER.
  2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS ( INCHES ).
  3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



- NOTES :
1. OUTLINE CONFORMS TO EIA-481.

### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
  - ② Starting  $T_J = 25^\circ\text{C}$ ,  $L = 6.4\text{mH}$   
 $R_G = 25\Omega$ ,  $I_{AS} = 5.6\text{A}$ .
  - ③  $I_{SD} \leq 5.6\text{A}$ ,  $di/dt \leq 110\text{A}/\mu\text{s}$ ,  $V_{DD} \leq V_{(BR)DSS}$ ,  
 $T_J \leq 175^\circ\text{C}$
  - ④ Pulse width  $\leq 300\mu\text{s}$ ; duty cycle  $\leq 2\%$ .
  - ⑤  $C_{oss}$  eff. is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$
- \* When mounted on 1" square PCB (FR-4 or G-10 Material).  
For recommended footprint and soldering techniques refer to application note #AN-994.

International  
**IR** Rectifier

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**IR EUROPEAN REGIONAL CENTRE:** 439/445 Godstone Rd, Whyteleafe, Surrey CR3 0BL, UK Tel: ++ 44 (0)20 8645 8000  
**IR CANADA:** 15 Lincoln Court, Brampton, Ontario L6T3Z2, Tel: (905) 453 2200  
**IR GERMANY:** Saalburgstrasse 157, 61350 Bad Homburg Tel: ++ 49 (0) 6172 96590  
**IR ITALY:** Via Liguria 49, 10071 Borgaro, Torino Tel: ++ 39 011 451 0111  
**IR JAPAN:** K&H Bldg., 2F, 30-4 Nishi-Ikebukuro 3-Chome, Toshima-Ku, Tokyo 171 Tel: 81 (0)3 3983 0086  
**IR SOUTHEAST ASIA:** 1 Kim Seng Promenade, Great World City West Tower, 13-11, Singapore 237994 Tel: ++ 65 (0)838 4630  
**IR TAIWAN:** 16 Fl. Suite D. 207, Sec. 2, Tun Haw South Road, Taipei, 10673 Tel: 886-(0)2 2377 9936

*Data and specifications subject to change without notice. 6/00*